

Supplementary Information

Scanning Electron Microscopy (SEM)

SEM micrograph of ED3A-MCM41 (FEI QUANTA INSPECT 200 LV) shows spherical particles having size smaller than 1 μm .

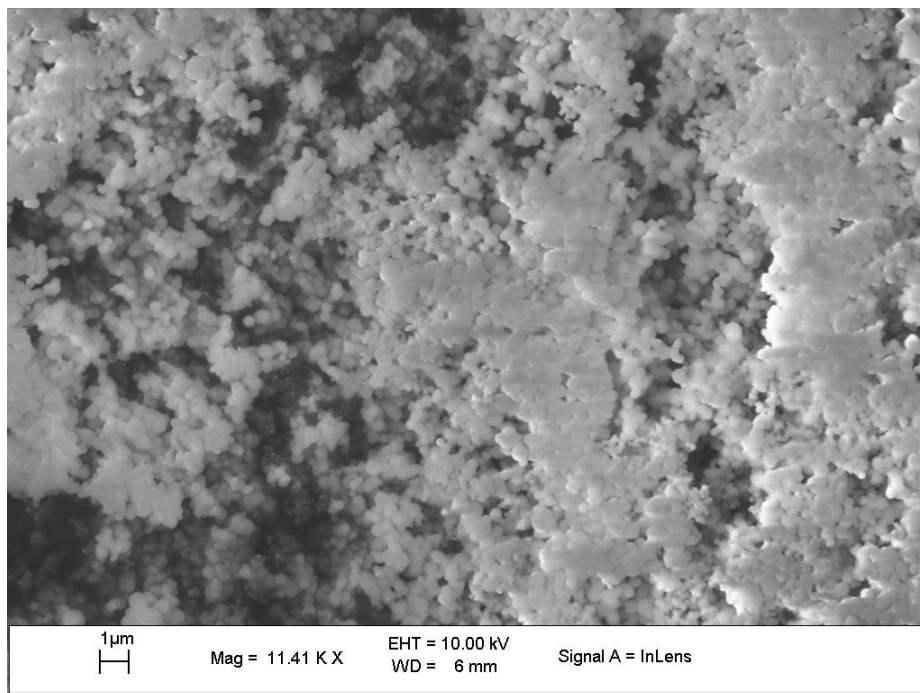


Fig S1 Scanning Electron Microscopy image of ED3A-MCM41